

Search Notes

Application/Control No.

10/760,651

Examiner

Raymond Phan

Applicant(s)/Patent under
Reexamination

TIERNEY ET AL.

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	309-315, 105-107, 110-112	10/7/2006	RP
710	240-244	10/7/2006	RP
711	138-146	10/7/2006	RP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	10/9/2006	RP